

**Notice of References Cited**Application/Control No.  
**09/437,499**Applicant(s)/Patent Under Reexam  
**Matsuura et al**Examiner  
**Mark Wallerson**Art Unit  
**2622**

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**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
A	5,921,537	7/1999	Matsui et al	270	1.03
B	5,126,786	6/1992	Tanaka	355	46
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**NON-PATENT DOCUMENTS**

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